

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

WALTHERUS W. VAN DEN HOOGENHOF

Application No.:

Filed:

For: **SAMPLE CONTAINER,  
MEASURING DEVICE AND  
METHOD FOR X-RAY ANALYSIS  
OF LIQUIDS**

Art Group:

Examiner:

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**REQUEST FOR PRIORITY**

Sir:

Applicant respectfully requests a convention priority for the above-captioned application, namely:

COUNTRY	APPLICATION NUMBER	DATE OF FILING
EPO	01200937.9	13 March 2001

A certified copy of the document is being submitted herewith.

Respectfully submitted,

Blakely, Sokoloff, Taylor & Zafman LLP

Eric S. Hyman, Reg. No. 30,139

Dated: 9/8/03

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